

	Type	L #	Hits	Search Text	DBs	Time Stamp
1	BRS	L1	5689	((determin\$5 or defect\$5 or measur\$5 or inspect\$5 or examin\$5) near4 (defect\$5 or moisture or oil or particle or foreign or imperfect\$5)) near8 film	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/27 08:31
2	BRS	L2	124256	(\$5sensor\$2 or \$5detect\$2) near4 (reference)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/27 08:22
3	BRS	L3	120	((((determin\$5 or defect\$5 or measur\$5 or inspect\$5 or examin\$5) near4 (defect\$5 or moisture or oil or particle or foreign or imperfect\$5)) near8 film ) and ((\$5sensor\$2 or \$5detect\$2) near4 (reference)) and @ad<=19991230	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/27 08:52
4	BRS	L4	74	(((((determin\$5 or defect\$5 or measur\$5 or inspect\$5 or examin\$5) near4 (defect\$5 or moisture or oil or particle or foreign or imperfect\$5)) near8 film ) and ((\$5sensor\$2 or \$5detect\$2) near4 (reference)) and @ad<=19991230) not semiconductor	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/27 08:23
5	BRS	L5	594	(router or convey\$5) with ((defect\$5 or moisture or oil or particle or foreign or imperfect\$5) near8 film)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/27 08:32
6	BRS	L6	2308	classif\$5 near10 film	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/27 08:33
7	BRS	L7	1	1 and 5 and 6 and ad<=19991230	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/27 08:52
8	BRS	L8	2	3 and 5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/27 08:52
9	BRS	L9	5	1 and 2 and 5 and ad<=19991230	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/27 08:56
10	BRS	L10	201919	digital near3 process\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/27 08:56
11	BRS	L11	26	1 and 2 and 10 and ad<=19991230	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/27 08:56